

**Notice of References Cited**Application/Control No.  
09/805,791Applicant(s)/Patent Under  
Reexamination  
PLANALP ET AL.Examiner  
Hanh B ThaiArt Unit  
2171

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,208,765 A	05-1993	Turnbull, Robert S.	702/84
	B	US-6,438,594 B1	08-2002	Bowman-Amuah, Michel K.	709/225
*	C	US-6,505,191 B1	01-2003	Baclawski, Kenneth P.	707/3
*	D	US-5,664,109	09-1997	Johnson et al.	705/2
*	E	US-6,052,693 A	04-2000	Smith et al.	707/104.1
*	F	US-5,646,862	07-1997	Jolliffe et al.	703/1
*	G	US-5,745,390	04-1998	Daneshgari, Parviz	702/119
*	H	US-6,341,287 B1	01-2002	Sziklai et al.	707/102
*	I	US-5,311,424 A	05-1994	Mukherjee et al.	705/29
*	J	US-6,353,824 B1	03-2002	Boguraev et al.	707/5
*	K	US-6,389,436 B1	05-2002	Chakrabarti et al.	715/513
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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